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# Sliding ferroelectricity in two-dimensional $\mathrm{MoA}_{2} \mathbf{N}_{4}$ ( $\mathrm{A}=\mathrm{Si}$ or Ge) bilayers: high polarizations and Moiré potentials $\dagger$ 

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According to the model of sliding ferroelectricity we proposed in 2017, a type of vertical polarization switchable via interlayer sliding may exist in a series of two-dimensional van der Waals bilayers and multilayers. Such intriguing ferroelectricity has been recently experimentally confirmed in BN and $\mathrm{WTe} \mathrm{e}_{2}$ bilayer/multilayer systems. However, they are respectively insulators and metals with weak polarizations. Here, we search for a combination of high-mobility semiconductors and ferroelectricity with relatively high polarizations, and we note that $\mathrm{MoSi}_{2} \mathrm{~N}_{4}$ monolayer has been recently fabricated to centimeter scale based on $\mathrm{MoN}_{2}$ monolayer (Science 2020, 369, 670). We show firstprinciples evidence of strong interlayer sliding ferroelectricity in high-mobility semiconducting $\mathrm{MoA}_{2} \mathrm{~N}_{4}(\mathrm{~A}=\mathrm{Si}$ or Ge) bilayers and multilayers. They possess tunable bandgaps within the desirable range for nanoelectronics, with the current highest polarizations in sliding ferroelectrics known to date due to strong interlayer van der Waals interactions. Such a successful combination of these properties may render the long-sought and efficient computing-in-memory possible. Their high polarizations induce strong Moiré potential and unique band alignments for exciton trapping in twisted $\mathrm{MoA}_{2} \mathrm{~N}_{4}$ bilayer. The varying charge distribution of different stacking in $\mathrm{MoN}_{2} / \mathrm{MoSi}_{2} \mathrm{~N}_{4}$ hetero-bilayer also gives rise to a high alternating voltage when used as a nanogenerator, suggesting promising potential for energy harvesting.

## Introduction

It is known that ferroelectric materials can be used as nonvolatile random access memory (RAM) devices due to their

[^0]switchable bi-states, which can represent logical "0" and " 1 ". Driven by the demand of miniaturization and integration of nanodevices, some recent research has been devoted to the search for ferroelectricity in two-dimensional (2D) materials with atomic thickness and clean van der Waals surface. ${ }^{1}$ Within several years, the existence of ferroelectricity in a series of 2D van der Waals materials ${ }^{2-11}$ have been experimentally confirmed, in which the ferroelectricity induced by interlayer sliding plays an important role. This mechanism ${ }^{12}$ is not available in traditional ferroelectrics but can be applied to many twodimensional materials: in many two-dimensional van der Waals bilayers, the upper and lower layers are not equivalent, giving rise to a net interlayer charge transfer, and the induced vertical polarization can be switched via interlayer sliding. This unique sliding ferroelectricity can widely exist in many van der Waals bilayers, multilayers and even bulk structures. The interlayer sliding barrier is much lower compared with traditional ferroelectrics, which may greatly save the required energy for ferroelectric switching. ${ }^{13}$

Currently, this type of interlayer sliding ferroelectricity has been experimentally confirmed in $\mathrm{BN}^{14,15}$ and $\mathrm{WTe}_{2}$ (ref. 16-19) bilayer/multilayer systems. However, they are respectively insulators and metals with weak polarizations. A successful combination of ferroelectricity and high-performance semiconductors is long-sought but remains elusive for conventional ferroelectrics, hindering their potential applications in nanoelectronics. Here, we search for ferroelectric high-mobility semiconductors with high polarizations. We note that a new member of 2D material family, $\operatorname{MoSi}_{2} \mathbf{N}_{4}$ monolayer, has been successful synthesized in a recent experiment, ${ }^{20}$ which can be viewed as a $\mathrm{MoN}_{2}$ monolayer sandwiched by two $\mathrm{Si}-\mathrm{N}$ layers. It has been shown to possess a moderate semiconducting bandgap, excellent stability in air and high hole mobility ( $\sim 1200 \mathrm{~cm}^{2} \mathrm{~V}^{-1} \mathrm{~s}^{-1}$ ). ${ }^{20}$ Subsequent calculations ${ }^{21,22}$ have further revealed some other members in 2D layered $\mathrm{MA}_{2} \mathrm{Z}_{4}(\mathrm{M}=\mathrm{Mo}, \mathrm{W}$ and Ti , early transition metal; $\mathrm{A}=\mathrm{Si}$ or $\mathrm{Ge} ; \mathrm{Z}=\mathrm{N}, \mathrm{P}$ or As ) family, which are structurally flexible due to vdW stacking. In this paper, we will show by first-principles calculations that
bilayer $\mathrm{MoSi}_{2} \mathrm{~N}_{4}$ and $\mathrm{MoGe}_{2} \mathrm{~N}_{4}$ are excellent candidates for achieving high interlayer sliding ferroelectricity in highperformance semiconductors.

## Results and discussion

In a very recent theoretical study, ${ }^{21}$ five different stacking configurations of $\mathrm{MoSi}_{2} \mathrm{~N}_{4}$ bilayer have been compared. The ground state turns out to be in the AB and AC stacking orders which are identical. Now we investigate the existence of interlayer sliding ferroelectricity for AB stacking (staggered) $\mathrm{MoSi}_{2} \mathrm{~N}_{4}$ bilayer, and the corresponding bi-stable states are displayed in Fig. 1(a). For state I, at the interlayer interface composed of two $\mathrm{Si}-\mathrm{N}$ layers, the N atoms of the upper layer are right over the Si atoms in the down layer, while the N atoms of the down layer are below the hexagon center (also the Mo atoms) of the upper layer. Such interlayer inequivalence gives rise to a net charge transfer and a vertical polarization, which can be switched via interlayer translation to the state II along either of the three directions marked by the green arrows, moving the Si and N atoms of the upper layer respectively right over the N atoms and Mo atoms in the down layer (see the red dotted lines). The areal density of interlayer charge transfer is estimated to be around $1.31 \mu \mathrm{C} \mathrm{cm}^{-2}$, making the upper/down layer respectively $\mathrm{p} / \mathrm{n}$ doped, which can be revealed by the interlayer differential charge density in Fig. 1(a).

It is the similar case for AB stacking $\mathrm{MoGe}_{2} \mathrm{~N}_{4}$ bilayer. The calculated vertical polarizations are $3.36 \mathrm{pC} \mathrm{m}^{-1}$ and 3.05 pC $\mathrm{m}^{-1}$ for $\mathrm{MoSi}_{2} \mathrm{~N}_{4}$ and $\mathrm{MoGe}_{2} \mathrm{~N}_{4}$, and $2.49 \mathrm{pC} \mathrm{m}^{-1}$ and 3.44 pC $\mathrm{m}^{-1}$ for $\mathrm{CrSi}_{2} \mathrm{~N}_{4}$ and $\mathrm{WSi}_{2} \mathrm{~N}_{4}$, respectively. They are much higher compared with bilayer $\mathrm{WTe}_{2}$ (predicted to be $\sim 0.37$ (ref. 17) and
experimentally measured to be $\sim 0.23 \mathrm{pC} \mathrm{m}^{-1}$ (ref. 18)) and BN ( $\sim 2 \mathrm{pC} \mathrm{m}^{-1}$ for both predictions ${ }^{12}$ and experimental measurements ${ }^{14}$ ). It may be attributed to the stronger interlayer interaction, noting that its interlayer distance of $2.81 \AA$ (the vertical distance between the N atoms of the upper and down layers at the van der Waals interface) is much smaller compared with bilayer graphene or BN (3.10-3.40 $\AA$ ). ${ }^{12}$ The nudge-elastic-band ${ }^{23}$ (NEB) method is used to estimate the energy barrier of slippageinduced polarization switching, which turns out to be respectively 20.20 and 33.23 meV per unit cell for $\mathrm{MoSi}_{2} \mathrm{~N}_{4}$ and $\mathrm{MoGe}_{2} \mathrm{~N}_{4}$ bilayer, as shown by the pathways in Fig. 1(b). Those values can also be obtained in the dependence of energy on interlayer displacement along the $x$ direction calculated in Fig. S1, $\dagger$ revealing typical double-well potentials for ferroelectrics.

The band structures of bilayer $\mathrm{MoSi}_{2} \mathrm{~N}_{4}$ and $\mathrm{MoGe}_{2} \mathrm{~N}_{4}$ in Fig. 2(a) are computed by using the Heyd-Scuseria-Ernzerhof (HSE) hybrid functional, ${ }^{24}$ revealing an indirect band gap of 2.10 eV for $\mathrm{MoSi}_{2} \mathrm{~N}_{4}$ and 0.98 eV for $\mathrm{MoGe}_{2} \mathrm{~N}_{4}$, within the desirable ranges for transistors. Meanwhile the electron mobility can reach $7990 \mathrm{~cm}^{2} \mathrm{~V}^{-1} \mathrm{~s}^{-1}$ according to our calculations in Table S1. $\dagger$ Such combination of non-volatile memories with high-mobility semiconductor transistors may enable computing-in-memory architecture where logic and arithmetic operations are performed in memory, which can greatly reduce energy cost associated with data transfer. ${ }^{25}$ The vertical polarization due to interlayer inequivalence also gives rise to the interlayer difference of distribution in band structures, splitting the bands of two layers by around $0.2-0.3 \mathrm{eV}$ that should be degenerate in energy without such polarization. As shown in Fig. 2(b), the valence band maximum (VBM) is distributed in the


Fig. 1 (a) Geometric structures of bilayer $\mathrm{MoSi}_{2} \mathrm{~N}_{4}$ and $\mathrm{MoGe}_{2} \mathrm{~N}_{4}$. I and II represent two equivalent states, where the polarization directions are marked by red arrows, the green arrow denotes the direction and distance from state I to state II upon interlayer sliding. For the interlayer differential charge density, green and red isosurfaces indicate electron depletion and accumulation after layer stacking, respectively. (b) The ferroelectric switching pathways of bilayer $\mathrm{MoSi}_{2} \mathrm{~N}_{4}$ and $\mathrm{MoGe}_{2} \mathrm{~N}_{4}$.


Fig. 2 (a) Band structures of bilayer $\mathrm{MoSi}_{2} \mathrm{~N}_{4}$ and $\mathrm{MoGe}_{2} \mathrm{~N}_{4}$. (b) Distributions of valence band maximum (VBM) and conduction band minimum (CBM) bands, and (c) PDOS analysis for bilayer $\mathrm{MoSi}_{2} \mathrm{~N}_{4}$
down layer while the conduction band minimum (CBM) is distributed in the upper layer (majorly around Mo atoms in the center). The partial projected density of states (PDOS) in Fig. 2(c) reveals that the bands closest to the Fermi level are mainly distributed by the $\mathrm{d}_{z}{ }^{2}$ orbital of Mo atoms and the $\mathrm{p}_{z}$ orbital of N atoms, where the splitting of the PDOS distributed by the two layers (see the splitting between N1 and N2, Mo1 and Mo2) is clearly displayed.

The distribution of the VBM and the CBM in Fig. 2(b) is distinct from most bilayer structures with considerable interlayer hybridizations. Taking the band structure of bilayer $\mathrm{MoS}_{2}$ in Fig. 3(a) as an example, for the non-polar $\mathrm{AA}^{\prime}$ stacking phase, VBM and CBM are distributed at both layers, indicating
interlayer hybridizations. It is the similar case for the VBM of the polar AB stacking phase, while its CBM is mainly distributed at the down layer due to its weak vertical polarization (predicted to be $0.97 \mathrm{pC} \mathrm{m}^{-1}$ ), ${ }^{12}$ where the band splitting due to its polarization is only 0.049 eV . In comparison, the large splitting of bands ( $0.2-0.3 \mathrm{eV}$ in Fig. 2(a)) in $\mathrm{MoSi}_{2} \mathrm{~N}_{4}$ bilayer is induced by the vertical polarization while the interlayer hybridization is trivial according to the distribution of the VBM and the CBM in Fig. 2(b). For 2D semiconducting bilayer with a small twist angle, the internal stacking translation $\mathbf{u}(\mathbf{r})$ varying gently with position $\mathbf{r}$ can control the local bandgap $E_{g}(\mathbf{u}(\mathbf{r})) .{ }^{26}$ Its Moiré potential was mainly induced by interlayer coupling and estimated to be in the order of tens of meV's in hetero-bilayers like






 down layer
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Fig. 4 (a) The dependences of polarizations and bandgaps of $A B C$ stacking $M o \operatorname{Si}_{2} N_{4}$ and $M o G e e_{2} N_{4}$ thin-layers on the thickness. (b) Different stacking configurations of $\mathrm{MoN}_{2} / \mathrm{MoSi}_{2} \mathrm{~N}_{4}$ hetero-bilayer with distinct interlayer potentials, which can be utilized as nanogenerators.
$\mathrm{MoSe}_{2} / \mathrm{WS}_{2}, \mathrm{MoSe}_{2} / \mathrm{MoS}_{2}$ and $\mathrm{MoTe}_{2} / \mathrm{MoSe}_{2}{ }^{27}$ For twisted $\mathrm{MoSi}_{2} \mathrm{~N}_{4}$ bilayer, however, the origin of Moiré potential will be the vertical polarization that induces the large band splitting instead of interlayer hybridization. The band alignments of different stacking regions are displayed in Fig. 3(b), indicating a quantum dot array with type-II heterojunctions (both in-plane and out-of-plane) that can greatly facilitate exciton trapping.

The ferroelectric phases for $\mathrm{MoSi}_{2} \mathrm{~N}_{4}$ and $\mathrm{MoGe}_{2} \mathrm{~N}_{4}$ multilayers with a higher thickness will be ABC stacking. For ABCstacked $\mathrm{MoSi}_{2} \mathrm{~N}_{4}$ and $\mathrm{MoGe}_{2} \mathrm{~N}_{4}$ multilayers, Fig. 4(a) shows the increasing trend in polarizations and declining trend in bandgaps with increasing number of layers. Compared with bilayer $\mathrm{MoSi}_{2} \mathrm{~N}_{4}$, the areal polarization is almost enhanced by 8 times while the bandgap decreases by almost half for six-layer $\operatorname{MoSi}_{2} \mathrm{~N}_{4}$. We also note that $\mathrm{MoSi}_{2} \mathrm{~N}_{4}$ monolayer was fabricated based on metallic $\mathrm{MoN}_{2}$ monolayer, which can also be used as a van der Waals electrical contact. ${ }^{28}$ It is noteworthy that the lattice mismatch between $\mathrm{MoN}_{2}$ and $\mathrm{MoSi}_{2} \mathrm{~N}_{4}$ is similar compared with the mismatch between graphene and BN monolayer ( $\sim 2 \%$ ), while the commensurate phase of graphene on BN with perfectly matching lattice constants has already been experimentally confirmed. ${ }^{29,30}$ Similar commensurate phase for $\mathrm{MoN}_{2} / \mathrm{MoSi}_{2} \mathrm{~N}_{4}$ heterobilayer is likely to be formed, as shown in Fig. 4(b), where the charge on metallic $\mathrm{MoN}_{2}$ monolayer will depend on the stacking configurations with distinct polarizations. To our Bader charge analysis, the difference of the charge on the $\mathrm{MoN}_{2}$ monolayer between AB 1 and AB 2 stacking configurations will be as high as 0.0413 e per unitcell. If the metallic $\mathrm{MoN}_{2}$ monolayer is dragged along an in-plane direction, the interlayer voltage will oscillate and an alternating current output signal will be generated, which can be used as a nanogenerator. By a coarse estimation using the formula $U=\frac{q \times d}{\varepsilon \times S}$, the alternating voltage will be around 1.6 V , almost 8 times higher compared with the previous design of the nanogenerator based on $\mathrm{C} / \mathrm{BN}$ hetero-bilayer, ${ }^{12}$ which can
greatly facilitate driving the flow of electrons and harvest energies. ${ }^{31-33}$

## Conclusion

In summary, through first-principles calculations we show the existence of strong interlayer sliding ferroelectricity in semiconducting $\mathrm{MoA}_{2} \mathrm{~N}_{4}(\mathrm{~A}=$ Si or Ge$)$ bilayers and multilayers, which may enable efficient computing-in-memory. They possess the current highest vertical polarizations in sliding ferroelectrics due to strong interlayer van der Waals interactions, while giving rise to intriguing band alignments with negligible interlayer hybridizations. The twisted $\mathrm{MoA}_{2} \mathrm{~N}_{4}$ bilayer with strong Moiré potential can be deemed as a quantum dot array with both in-plane and out-of-plane type-II heterojunctions that can greatly facilitate exciton trapping. In addition, $\mathrm{MoN}_{2} / \mathrm{MoSi}_{2} \mathrm{~N}_{4}$ hetero-bilayer can be utilized as an efficient nanogenerator, suggesting promising potentials for energy harvesting.

## Methods

Our calculations were performed based on density functional theory (DFT) methods implemented in the Vienna Ab initio Simulation Package (VASP 5.4.4) code. ${ }^{34,35}$ The generalized gradient approximation (GGA) in the Perdew-Burke-Ernzerhof $(\mathrm{PBE})^{36}$ exchange-correlation functional and the projector augmented wave (PAW) ${ }^{37}$ formalism were adopted. The kinetic energy cutoff was set at 500 eV . For the geometry optimization, PBE-D2 method of Grimme was used to take vdW interaction into account, ${ }^{38}$ and the Brillouin zone was sampled by a $\Gamma$ centered $9 \times 9 \times 1 k$ points using the Monkhorst-Pack scheme. ${ }^{39}$ All systems were fully relaxed, the convergence threshold for self-consistent-field iteration was set to be $10^{-6} \mathrm{eV}$ and the atomic positions were fully optimized until the forces on all atoms are less than $0.01 \mathrm{eV} \AA^{-1}$. A vacuum space of $20 \AA$
was set in the vertical direction. The Berry phase method was employed to evaluate the polarizations of the thin film $\mathrm{MoSi}_{2} \mathrm{~N}_{4}$ and $\mathrm{MoGe}_{2} \mathrm{~N}_{4} .{ }^{40}$

## Conflicts of interest

There are no conflicts to declare.

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